Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NUROK ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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NON-PATENT DOCUMENTS

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	U	Two Records from Dialog regarding Nurok (Journal of Planar Chromatography, Vol. 11, July/August 1998, pages 244-246), two pages.			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.